

# FDW2508PB

## Dual P-Channel $-1.8V$ Specified PowerTrench® MOSFET

$-12V, -6A, 18m\Omega$

### Features

- Max  $r_{DS(on)}$  =  $18m\Omega$  at  $V_{GS} = -4.5V, I_D = -6A$
- Max  $r_{DS(on)}$  =  $22m\Omega$  at  $V_{GS} = -2.5V, I_D = -5A$
- Max  $r_{DS(on)}$  =  $30m\Omega$  at  $V_{GS} = -1.8V, I_D = -4A$
- Low gate charge
- High performance trench technology for extremely low  $r_{DS(on)}$
- Low profile TSSOP-8 package
- RoHS compliant

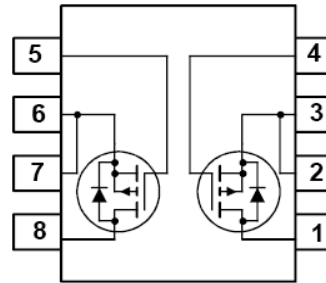
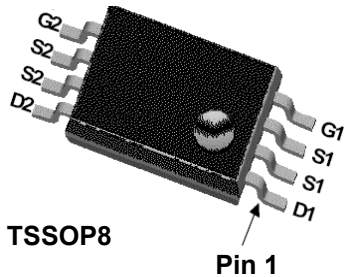


### General Description

This P-Channel  $-1.8V$  specified MOSFET uses Fairchild Semiconductor's advanced low voltage PowerTrench®. It has been optimized for battery power management applications.

### Application

- Power management
- Load switch
- Battery protection



### MOSFET Maximum Ratings $T_A = 25^\circ C$ unless otherwise noted

Symbol	Parameter	Rated	Units
$V_{DS}$	Drain to Source Voltage	-12	V
$V_{GS}$	Gate to Source Voltage	$\pm 8$	V
$I_D$	Drain Current -Continuous (Note 1a)	-6	A
	-Pulsed	-30	
$P_D$	Power Dissipation-Dual Operation	2	W
	Power Dissipation-Single Operation (Note 1a)	1.6	
	(Note 1b)	1	
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ C$

### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	80	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	125	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
2508PB	FDW2508PB	TSSOP-8	13"	12mm	2500 units

## Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	-12			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$		-12		$\text{mV}/^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -10\text{V}$ $V_{GS} = 0\text{V}$ $T_J = 125^\circ\text{C}$			-1 -100	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 8\text{V}, V_{DS} = 0\text{V}$			$\pm 100$	nA

### On Characteristics (Note 2)

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\mu\text{A}$	-0.4	-0.6	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\mu\text{A}$ , referenced to $25^\circ\text{C}$		3		$\text{mV}/^\circ\text{C}$
$r_{DS(on)}$	Static Drain to Source On-Resistance	$V_{GS} = -4.5\text{V}, I_D = -6\text{A}$		15	18	$\text{m}\Omega$
		$V_{GS} = -2.5\text{V}, I_D = -5\text{A}$		18	22	
		$V_{GS} = -1.8\text{V}, I_D = -4\text{A}$		22	30	
		$V_{GS} = -4.5\text{V}, I_D = -6\text{A}, T_J = 125^\circ\text{C}$		23	30	
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{V}, I_D = -6\text{A}$		35		S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = -6\text{V}, V_{GS} = 0\text{V},$ $f = 1\text{MHz}$		2835	3775	pF
$C_{oss}$	Output Capacitance			440	590	pF
$C_{rss}$	Reverse Transfer Capacitance			370	555	pF

### Switching Characteristics

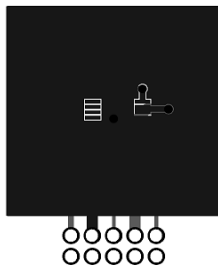
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -6\text{V}, I_D = -6\text{A}$ $V_{GS} = -4.5\text{V}, R_{GEN} = 6\Omega$		8	16	ns
$t_r$	Rise Time			16	29	ns
$t_{d(off)}$	Turn-Off Delay Time			254	407	ns
$t_f$	Fall Time			106	170	ns
$Q_g$	Total Gate Charge		$V_{GS} = -4.5\text{V}, V_{DD} = -6\text{V}$ $I_D = -6\text{A}$		32	45
$Q_{gs}$	Gate to Source Gate Charge			4.3		nC
$Q_{gd}$	Gate to Drain "Miller" Charge			7.1		nC

### Drain-Source Diode Characteristics

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{V}, I_S = -1.1\text{A}$ (Note 2)		-0.6	-1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F = -6\text{A}, di/dt = 100\text{A}/\mu\text{s}$		106	159	ns
$Q_{rr}$	Reverse Recovery Charge			110	165	nC

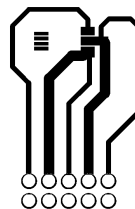
#### Notes:

1:  $R_{\theta JA}$  is the sum of junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $R_{\theta JA}$  is  $80^\circ\text{C}/\text{W}$  (steady state) when mounted on a  $1\text{ in}^2$  pad of 2 oz copper.

Scale 1 : 1 on letter size paper



b.  $R_{\theta JA}$  is  $125^\circ\text{C}/\text{W}$  (steady state) when mounted on a minimum pad.

2: Pulse Test: Pulse Width <  $300\mu\text{s}$ , Duty cycle < 2.0%.

**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted

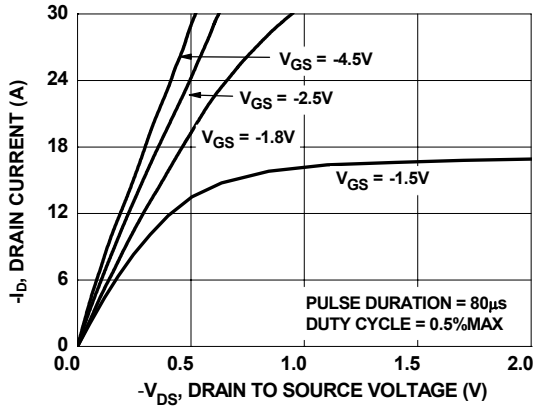


Figure 1. On Region Characteristics

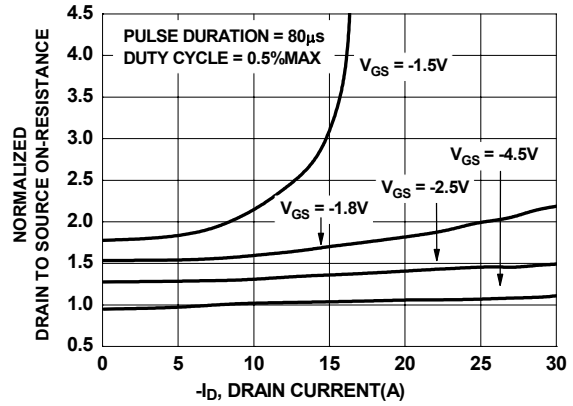


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

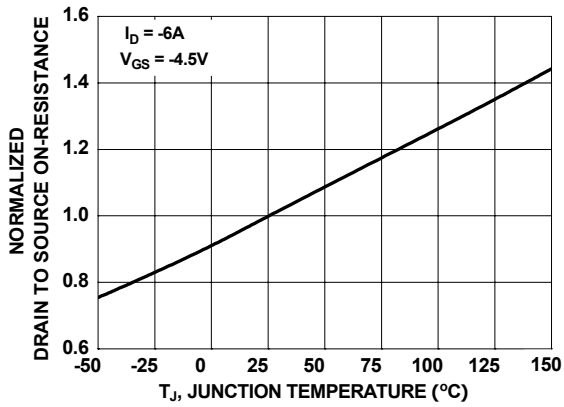


Figure 3. Normalized On Resistance vs Junction Temperature

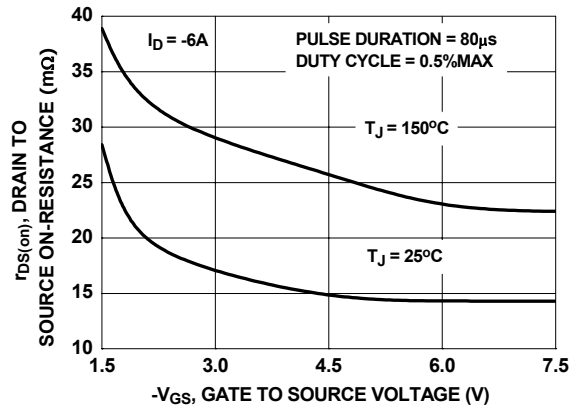


Figure 4. On-Resistance vs Gate to Source Voltage

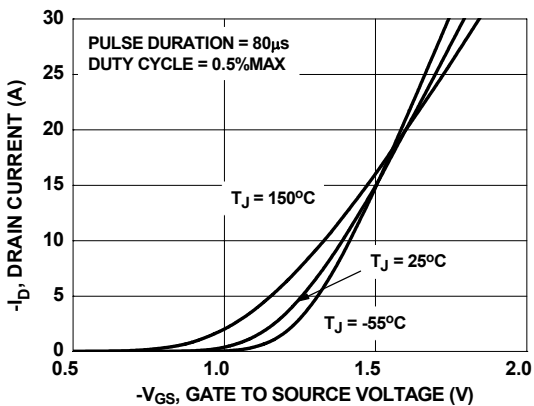


Figure 5. Transfer Characteristics

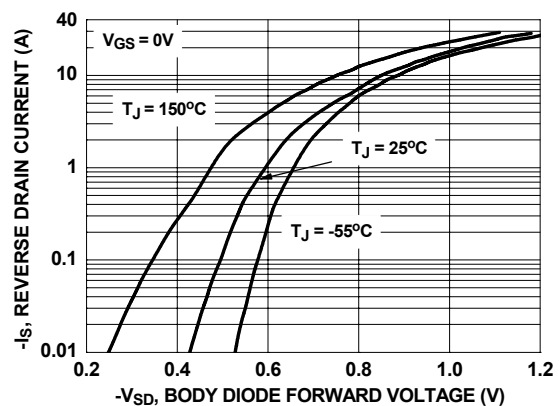
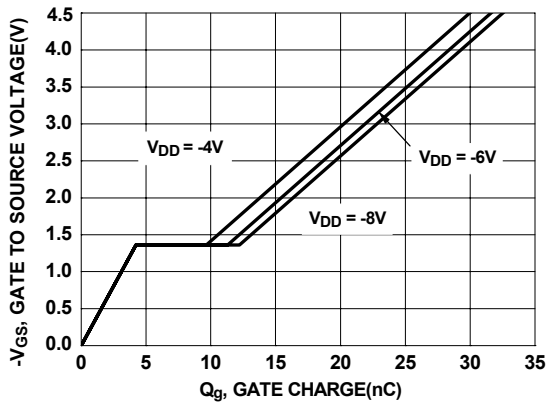
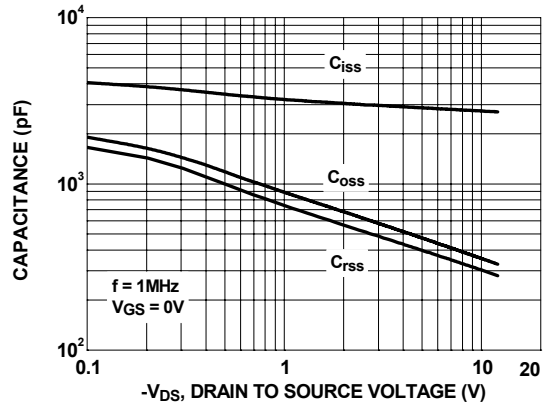


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

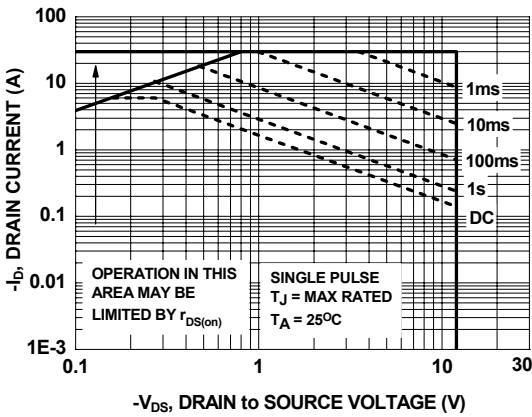
**Typical Characteristics**  $T_J = 25^\circ\text{C}$  unless otherwise noted



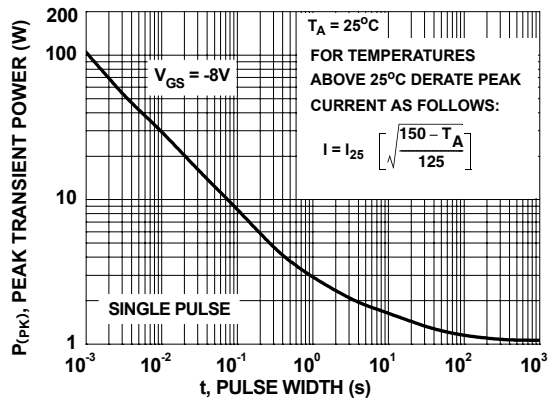
**Figure 7. Gate Charge Characteristics**



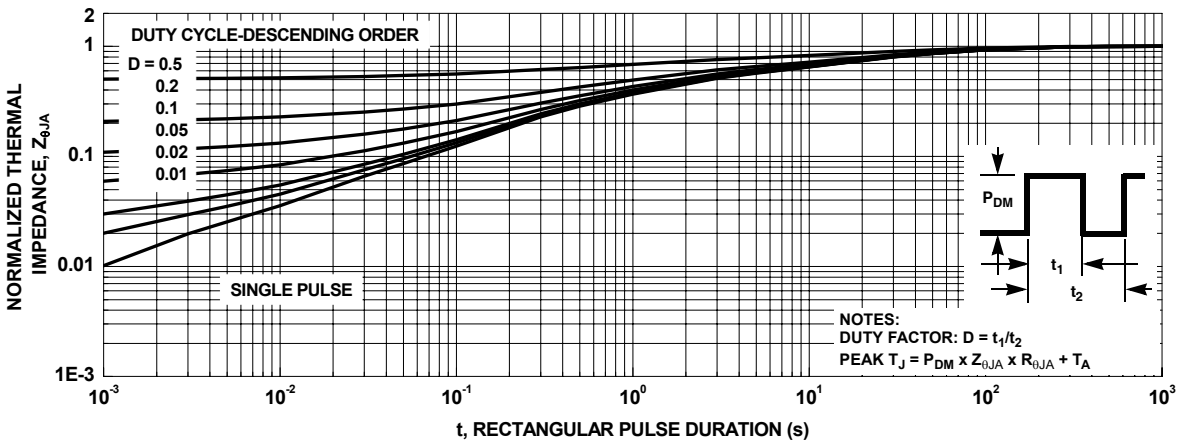
**Figure 8. Capacitance vs Drain to Source Voltage**



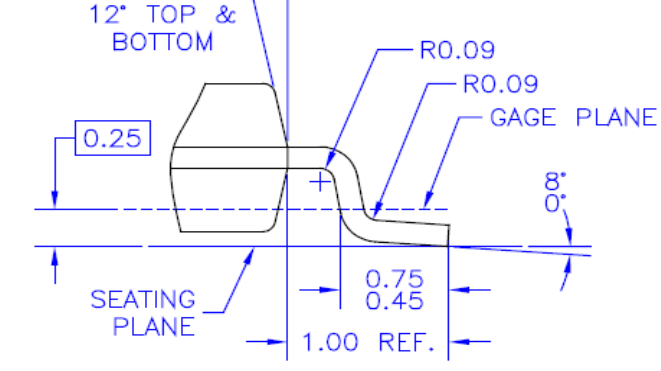
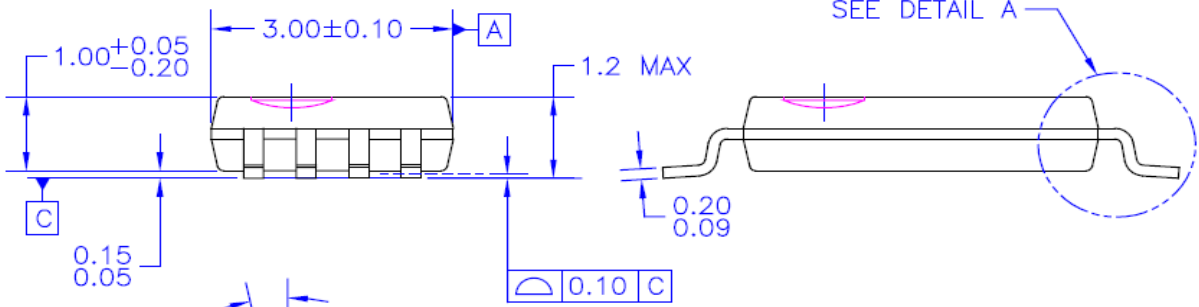
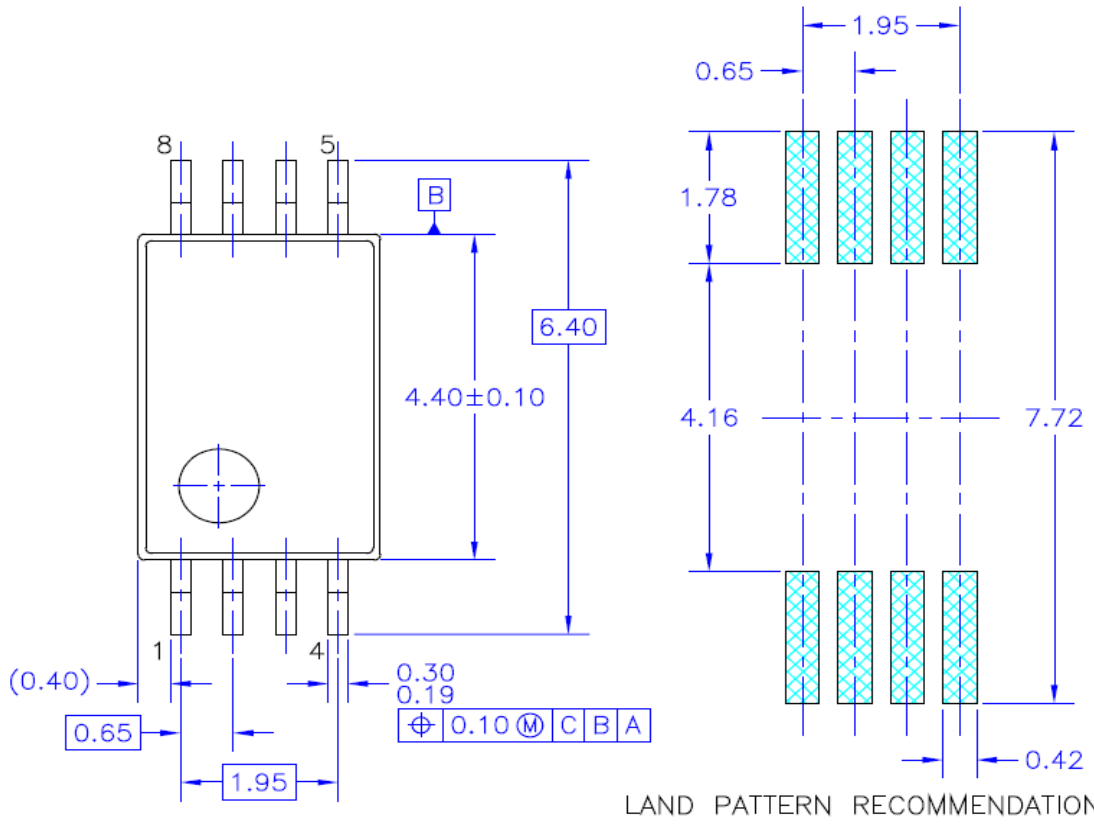
**Figure 9. Forward Bias Safe Operating Area**



**Figure 10. Single Pulse Maximum Power Dissipation**



**Figure 11. Transient Thermal Response Curve**



- NOTES: UNLESS OTHERWISE SPECIFIED
- A) THIS PACKAGE CONFORMS TO JEDEC MO-153, ISSUE E, VARIATION AA, DATED OCTOBER 1997.
  - B) ALL DIMENSIONS ARE IN MILLIMETERS.
  - C) DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
  - D) DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

DETAIL A  
SCALE: 2X

MTC08REVB

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